

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination WATANABE ET AL.	
		Examiner Kenan Cehic	Art Unit 2616	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,717,691 A	02-1998	Dighe et al.	370/401
*	B	US-6,075,772 A	06-2000	Brown et al.	370/235
*	C	US-2001/0055313 A1	12-2001	YIN et al.	370/466
*	D	US-6,438,551 B1	08-2002	Holmskar, Stig	707/10
*	E	US-2003/0093628 A1	05-2003	Matter et al.	711/153
*	F	US-6,678,283 B1	01-2004	Teplitsky, Yakov	370/463
*	G	US-6,789,203 B1	09-2004	Belissent, Jacques E.	726/22
*	H	US-6,425,091	07-2002	Yang et al.	713/600
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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